Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/814,949	CROSLAND ET AL.	
Examiner	Art Unit	
Christopher B. Shin	2181	

SEARCHED					
Class	Subclass	Date	Examiner		
713	300-340	9/22/2006	cs		
710	72-74	9/22/2006	cs		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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	1				

SEARCH (INCLUDING SEAR		)
	DATE	EXMR
PLUS	9/22/2006	cs
PALM (Double Patenting)	9/22/2006	cs
EAST (See Search Notes)	9/22/2006	cs
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